

## Deutsche Akkreditierungsstelle GmbH

# Annex to the Accreditation Certificate D-K-19708-01-00 according to DIN EN ISO/IEC 17025:2018

Valid from: 03.12.2019

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Holder of certificate:

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Calibration in the fields:

**Electrical quantities** 

DC and low frequency quantities

- -DC voltage
- -AC voltage
- -DC current

High frequency quantities

-HF voltage

Time and frequency quantities

-Time interval

Abbreviations used: see last page



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### **Permanent laboratory**

Measured quantity / Calibration item	Range			Measurement conditions / procedure	Best measurement capability 1)	Rer	narks
DC voltage	0 V	to 1	.00 mV		2 μV	U = measured value	
voltage sources	> 0.10 V	to	1 V		3.8 · 10 <sup>-6</sup> · <b>♂</b> + 0.29 μV		
	> 1 V	to	10 V		3.8 · 10 <sup>-6</sup> · <b>U</b> + 0.48 µV		
	> 10 V	to	30 V		5.7 · 10 <sup>-6</sup> · <b>V</b> + 29 μV		
DC current	0 A	to	10 μΑ		2.1 nA	I = measured value	
current sources	> 10 µA	to 1	100 μΑ		21 nA		
	> 0.1 mA	to	1 mA		28 · 10 <sup>-6</sup> · <b>I</b> + 57 nA		
	> 1 mA	to	10 mA		0.19 · 10 <sup>-3</sup> · <b>I</b> + 0.61 μA		
	> 10 mA	to 1	.00 mA		0.67 · 10 <sup>-3</sup> · <b>[</b> + 1.3 μA		
	> 0.1 A	to	1 A		0.21 · 10 <sup>-3</sup> · <b>[</b> + 49 μA		
AC voltage	1 mV	to	10 mV	100 kHz	5.0 · 10 <sup>-3</sup> · <b>U</b> + 1.1 μV	U = measured value	
	> 10 mV	to 1	.00 mV		0.85 · 10 <sup>-3</sup> · <b>U</b> + 2.5 μV		
	> 0.1 V	to	1 V		0.83 · 10 <sup>-3</sup> · <b>V</b> + 26 μV		
	> 1 V	to	3 V		0.84 · 10 <sup>-3</sup> · <b>U</b> + 0.23 mV		
HF voltage $U_{\rm in}$ measuring instruments	1 mV	to	10 mV	100 kHz to 30 MHz	11 · 10 <sup>-3</sup>	$\left  \begin{array}{c} \left  \Gamma_{\rm X} \right  \leq 0.1 \\ U_{\rm in} = {\rm incoming\ voltage\ in\ a} \\ 50\ \Omega \ {\rm system} \end{array} \right $	
	> 10 mV	to	3 V		9.0 · 10 <sup>-3</sup>		
HF voltage $U_{Z0}$ generators	1 mV	to	10 mV		9.6 · 10 <sup>-3</sup>	$\left  \begin{array}{c} \left  \Gamma_{\rm G} \right  \leq 0.1 \\ U_{\rm Zn} = { m output} \ { m voltage} \ { m in} \ { m a} \end{array} \right $	
	> 10 mV	to	3 V		7.1 · 10 <sup>-3</sup>	50 Ω system	
Time interval <u>∆</u> ‡	0.5 ns	to	1 μs		0.30 ns	$k = 0.95 \cdot \sqrt{3}$	<u>∆t</u> = measure
	> 1 µs	to	10 μs		$23 \cdot 10^{-6} \cdot \Delta t + 0.28 \text{ ns}$	K = 2	d value
	> 10 µs	to	10 ms		$41 \cdot 10^{-6} \cdot \Delta t + 0.1 \text{ ns}$	$k = 0.95 \cdot \sqrt{3}$	- <b>∦</b> : coverage factor

#### Abbreviations used:

CMC Calibration and measurement capabilities (Kalibrier- und Messmöglichkeiten)

 $|\Gamma_{\rm X}|$  Absolute value of the reflection factor at the 50  $\Omega$  input of the measuring instrument to be calibrated

 $|\Gamma_{\rm G}|$  Absolute value of the reflection factor at the 50  $\Omega$  output of the generator to be calibrated

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 $<sup>^{1)}</sup>$  The expanded uncertainties according to EA-4/02 M:2013 are part of CMC and are the best measurement uncertainties within accreditation. They have a coverage probability of approximately 95 % and have a coverage factor of k=2 unless stated otherwise. Uncertainties without unit are relative uncertainties referring to the measurement value unless stated otherwise.